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Substitute for form 1449/PTO		Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>		Application Number	10/579,766-Conf. #3580
		Filing Date	May 18, 2006
		First Named Inventor	Takamitsu Yamada
		Art Unit	2827
		Examiner Name	Not Yet Assigned
Sheet	1	of	1
		Attorney Docket Number	R2184.0495/P495

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

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NON PATENT LITERATURE DOCUMENTS				
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	CA	TASIRAN et al.; "Linking Simulation with Formal Verification at a Higher Level"; Synergies for Design Verification; IEEE Design & Test of Computers; Vol. 21, No. 6; Jun 2004; pp. 472-482.		
	CB	CHEN et al.; "Logic of Constraints: A Quantitative Performance and Functional Constraint Formalism"; IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems; Vol. 23, No. 8; August 2004; pp. 1243-1255.		
	CC	DATTA et al.; "Assertion Based Verification Using HDVL"; Proceedings of the 17th International Conference on VLSI Design; Jan. 2004; pp. 319-325.		
	CD	PIXLEY et al.; "Functional Verification 2003: Technology, Tools and Methodology"; Proceedings 5th International Conference, IEEE; Vol. 1, Oct. 2003; pp. 1-5.		

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